

74AVC16374

16-bit edge triggered D-type flip-flop; 3.6 V tolerant; 3-state

Rev. 3 — 16 August 2013

Product data sheet

1. General description

The 74AVC16374 is a 16-bit edge triggered flip-flop featuring separate D-type inputs for each flip-flop and 3-state outputs for bus-oriented applications. The 74AVC16374 consist of 2 sections of 8 edge-triggered flip-flops. A clock input (CP) and an output enable ($\overline{OE}$) are provided per 8-bit section.

The 74AVC16374 is designed to have an extremely fast propagation delay and a minimum amount of power consumption.

To ensure the high-impedance output state during power-up or power-down, $\overline{nOE}$ should be tied to VCC through a pull-up resistor (Live Insertion).

A Dynamic Controlled Output (DCO) circuitry is implemented to support termination line drive during transient (see [Figure 5](#) and [Figure 6](#)).

2. Features and benefits

- Wide supply voltage range from 1.2 V to 3.6 V
- Complies with JEDEC standards:
 - ◆ JESD8-7 (1.2 V to 1.95 V)
 - ◆ JESD8-5 (1.8 V to 2.7 V)
 - ◆ JESD8-1A (2.7 V to 3.6 V)
- CMOS low power consumption
- Input/output tolerant up to 3.6 V
- Dynamic Controlled Output (DCO) circuit dynamically changes output impedance, resulting in noise reduction without speed degradation
- Low inductance multiple V_{CC} and GND pins to minimize noise and ground bounce
- Supports Live Insertion

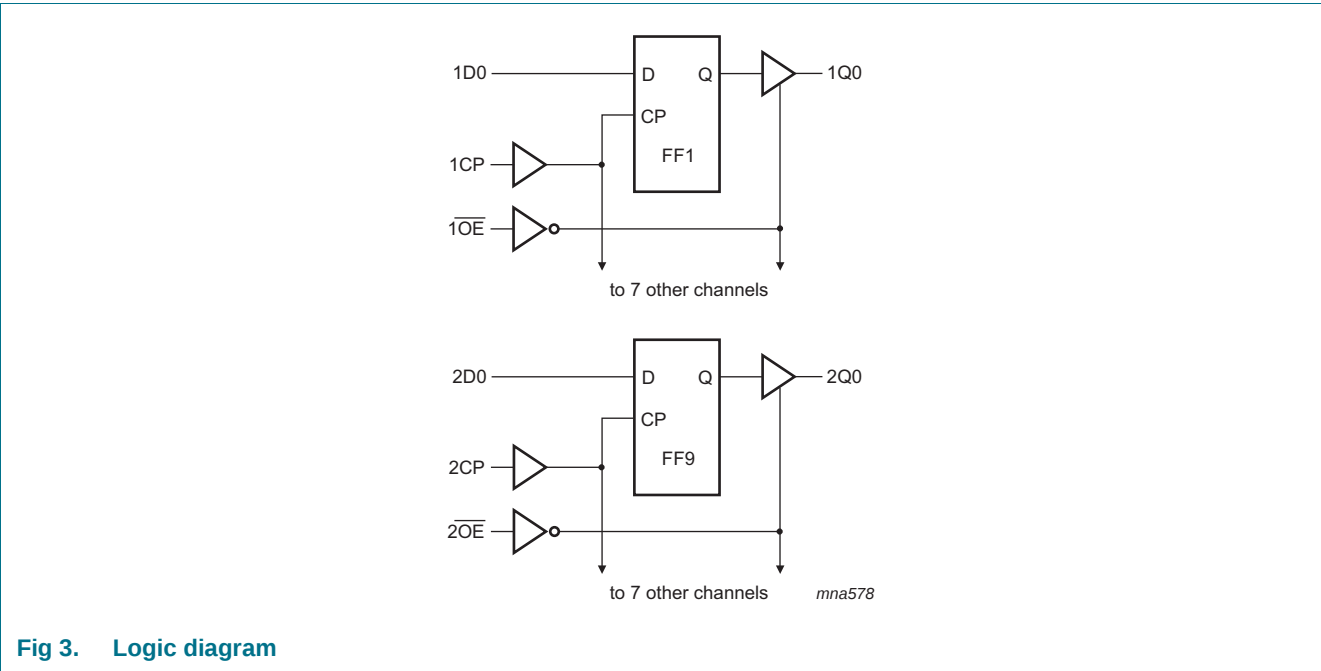
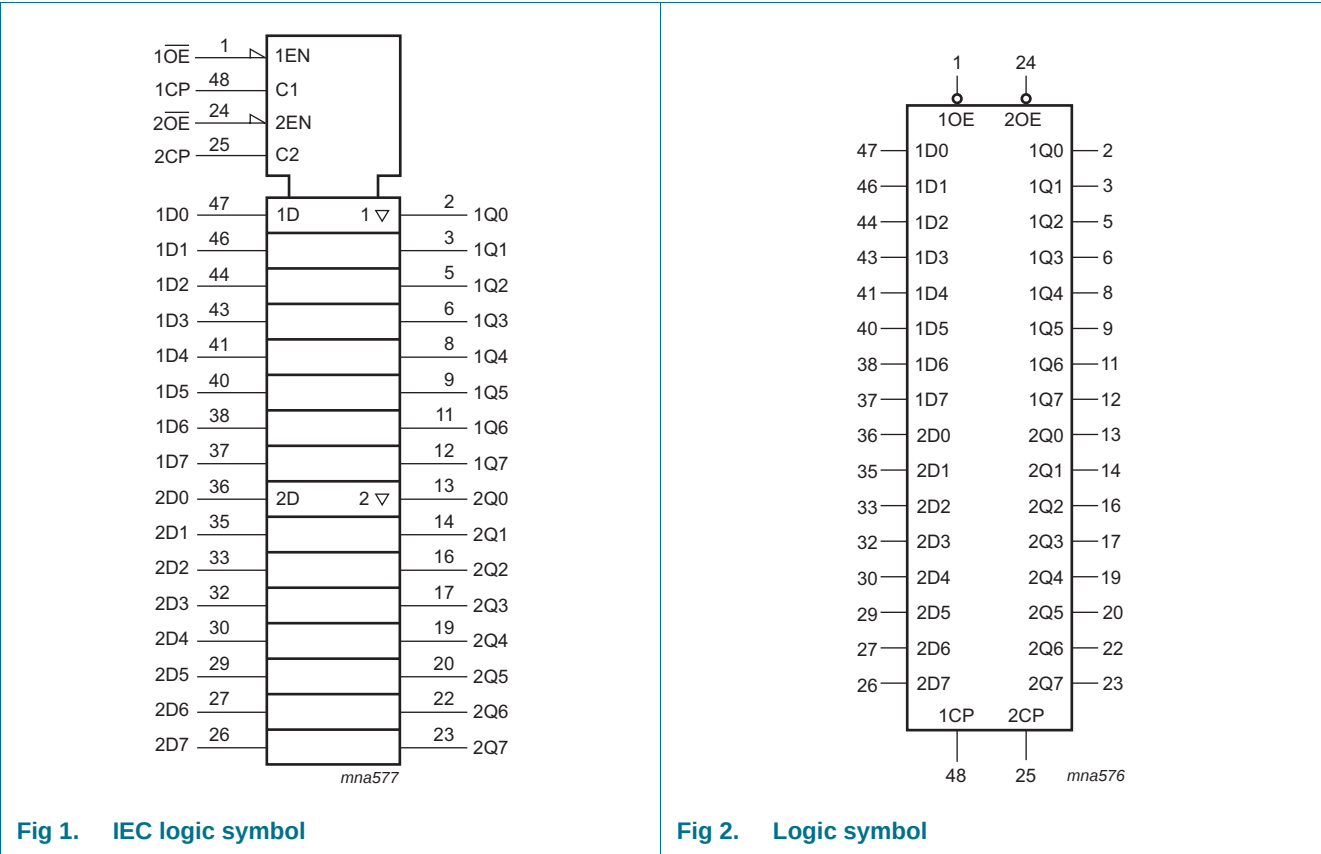
3. Ordering information

Table 1. Ordering information

Type number	Package			
	Temperature range	Name	Description	Version
74AVC16374DGG	–40 °C to +85 °C	TSSOP48	plastic thin shrink small outline package; 48 leads; body width 6.1 mm	SOT362-1



4. Functional diagram



5. Pinning information

5.1 Pinning

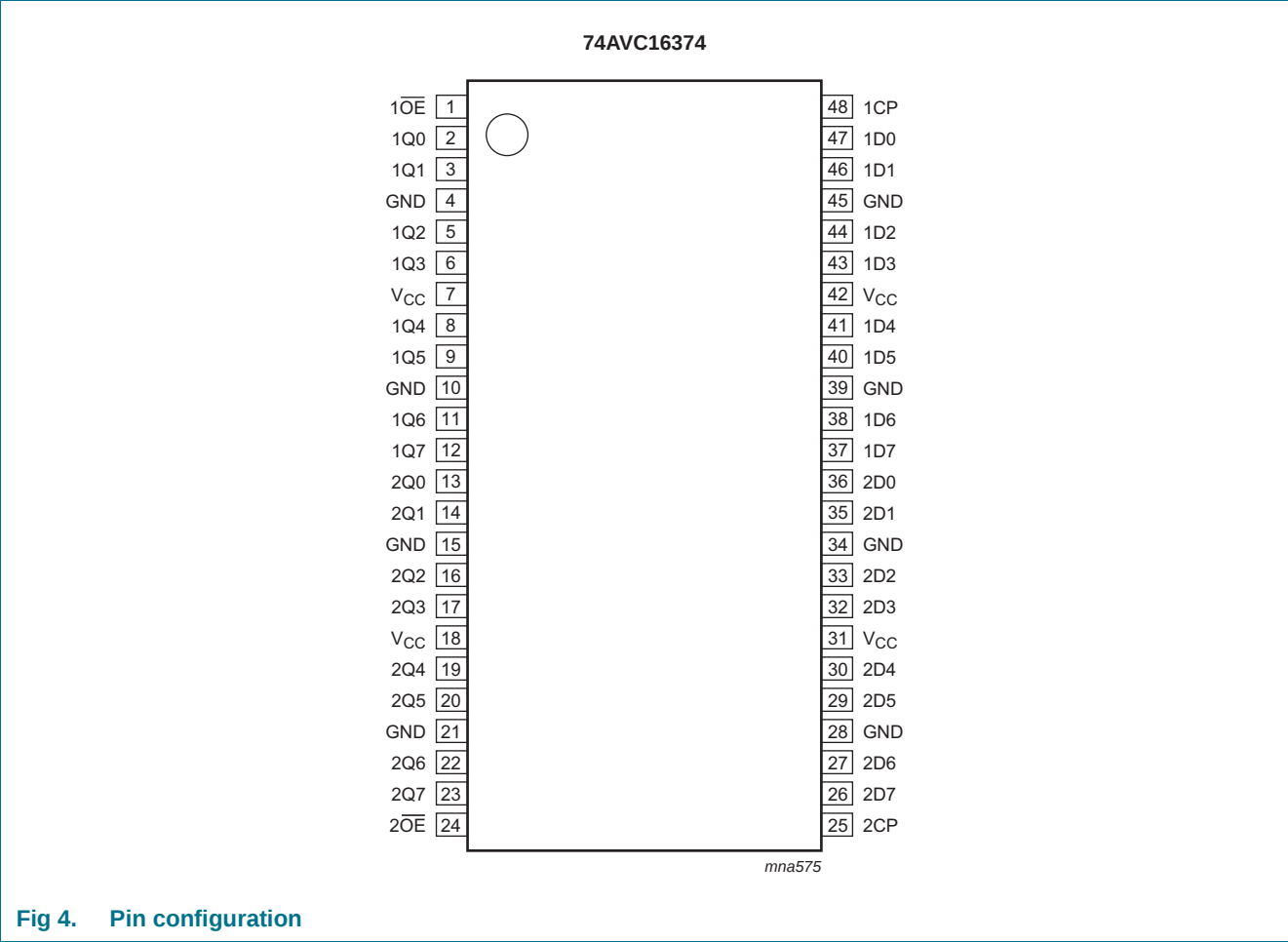


Fig 4. Pin configuration

5.2 Pin description

Table 2. Pin description

Symbol	Pin	Description
$\overline{1OE}$	1	output enable input (active LOW)
1Q0 to 1Q7	2, 3, 5, 6, 8, 9, 11, 12	3-state flip-flop outputs
GND	4, 10, 15, 21, 28, 34, 39, 45	ground (0 V)
V _{CC}	7, 18, 31, 42	supply voltage
2Q0 to 2Q7	13, 14, 16, 17, 19, 20, 22, 23	3-state flip-flop outputs
$\overline{2OE}$	24	output enable input (active LOW)
2CP	25	clock input
2D0 to 2D7	36, 35, 33, 32, 30, 29, 27, 26	data input/output
1D0 to 1D7	47, 46, 44, 43, 41, 40, 38, 37	data input/output
1CP	48	clock input

6. Functional description

Table 3. Function table^[1]

Operating modes	Inputs			Internal flip-flops	Outputs
	$\overline{nOE}$	nCp	nDn		nQn
Load and read register	L	↑	l	L	L
	L	↑	h	H	H
Load register and disable outputs	H	↑	l	L	Z
	H	↑	h	H	Z

[1] H = HIGH voltage level

h = HIGH voltage level one set-up time prior to the LOW-to-HIGH CP transition

L = LOW voltage level

l = LOW voltage level one set-up time prior to the LOW-to-HIGH CP transition

Z = high-impedance OFF-state

↑ = LOW-to-HIGH CP transition

7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{CC}	supply voltage		-0.5	+4.6	V
I_{IK}	input clamping current	$V_I < 0$ V	-	-50	mA
V_I	input voltage		[1] -0.5	+4.6	V
I_{OK}	output clamping current	$V_O < 0$ V	-50	-	mA
V_O	output voltage	output HIGH or LOW	[1] -0.5	$V_{CC} + 0.5$	V
		output 3-state	[1] -0.5	+4.6	V
I_O	output current	$V_O = 0$ V to V_{CC}	-	± 50	mA
I_{CC}	supply current		-	+100	mA
I_{GND}	ground current		-100	-	mA
T_{stg}	storage temperature		-65	+150	°C
P_{tot}	total power dissipation	$T_{amb} = -40$ °C to +85 °C	[2] -	500	mW

[1] The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

[2] Above 60 °C, the value of P_{tot} derates linearly with 5.5 mW/K.

8. Recommended operating conditions

Table 5. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V_{CC}	supply voltage	according to JEDEC Low Voltage Standards	1.4	-	1.6	V
			1.65	-	1.95	V
			2.3	-	2.7	V
			3.0	-	3.6	V
		for low-voltage applications	1.2	-	3.6	V
V_I	input voltage		0	-	3.6	V
V_O	output voltage	output HIGH or LOW	0	-	V_{CC}	V
		output 3-state	0	-	3.6	V
T_{amb}	ambient temperature	in free air	-40	-	+85	°C
$\Delta t/\Delta V$	input transition rise and fall rate	$V_{CC} = 1.4$ V to 1.6 V	0	-	40	ns/V
		$V_{CC} = 1.65$ V to 2.3 V	0	-	30	ns/V
		$V_{CC} = 2.3$ V to 3.0 V	0	-	20	ns/V
		$V_{CC} = 3.0$ V to 3.6 V	0	-	10	ns/V

9. Static characteristics

Table 6. Static characteristics

At recommended operating conditions. Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Typ ^[1]	Max	Unit
T_{amb} = -40 °C to +85 °C						
V _{IH}	HIGH-level input voltage	V _{CC} = 1.2 V	V _{CC}	-	-	V
		V _{CC} = 1.4 V to 1.6 V	0.65 × V _{CC}	0.9	-	V
		V _{CC} = 1.65 V to 1.95 V	0.65 × V _{CC}	0.9	-	V
		V _{CC} = 2.3 V to 2.7 V	1.7	1.2	-	V
		V _{CC} = 3.0 V to 3.6 V	2.0	1.5	-	V
V _{IL}	LOW-level input voltage	V _{CC} = 1.2 V	-	-	GND	V
		V _{CC} = 1.4 V to 1.6 V	-	0.9	0.35 × V _{CC}	V
		V _{CC} = 1.65 V to 1.95 V	-	0.9	0.35 × V _{CC}	V
		V _{CC} = 2.3 V to 2.7 V	-	1.2	0.7	V
		V _{CC} = 3.0 V to 3.6 V	-	1.5	0.8	V
V _{OH}	HIGH-level output voltage	V _I = V _{IH} or V _{IL}				
		I _O = -100 μA; V _{CC} = 1.65 V to 3.6 V	V _{CC} - 0.20	V _{CC}	-	V
		I _O = -3 mA; V _{CC} = 1.4 V	V _{CC} - 0.35	V _{CC} - 0.23	-	V
		I _O = -4 mA; V _{CC} = 1.65 V	V _{CC} - 0.45	V _{CC} - 0.25	-	V
		I _O = -8 mA; V _{CC} = 2.3 V	V _{CC} - 0.55	V _{CC} - 0.38	-	V
		I _O = -12 mA; V _{CC} = 3.0 V	V _{CC} - 0.70	V _{CC} - 0.48	-	V
V _{OL}	LOW-level output voltage	V _I = V _{IH} or V _{IL}				
		I _O = 100 μA; V _{CC} = 1.65 V to 3.6 V	-	GND	0.20	V
		I _O = 3 mA; V _{CC} = 1.4 V	-	0.10	0.35	V
		I _O = 4 mA; V _{CC} = 1.65 V	-	0.10	0.45	V
		I _O = 8 mA; V _{CC} = 2.3 V	-	0.26	0.55	V
		I _O = 12 mA; V _{CC} = 3.0 V	-	0.36	0.70	V
I _I	input leakage current	per pin; V _I = V _{CC} or GND; V _{CC} = 1.4 V to 3.6 V	-	0.1	2.5	μA
I _{OFF}	power-off leakage current	V _I or V _O = 3.6 V; V _{CC} = 0.0 V	-	±0.1	±10	μA
I _{OZ}	OFF-state output current	V _I = V _{IH} or V _{IL} ; V _O = V _{CC} or GND				
		V _{CC} = 1.4 V to 2.7 V	-	0.1	5	μA
		V _{CC} = 3.0 V to 3.6 V	-	0.1	10	μA
I _{CC}	supply current	V _I = V _{CC} or GND; I _O = 0 A				
		V _{CC} = 1.4 V to 2.7 V	-	0.1	20	μA
		V _{CC} = 3.0 V to 3.6 V	-	0.2	40	μA
C _I	input capacitance		-	5	-	pF

[1] All typical values are measured at T_{amb} = 25 °C.

9.1 Graphs

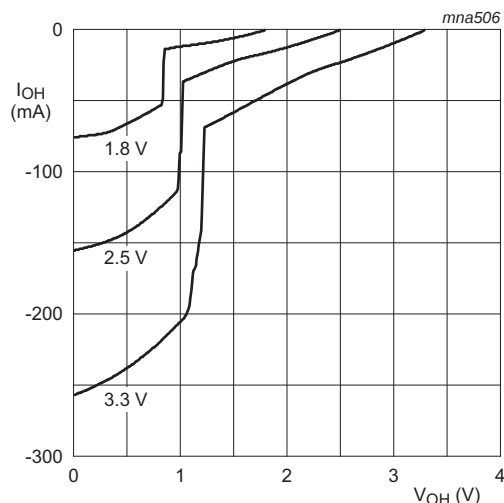


Fig 5. Output voltage as a function of the HIGH-level output current.

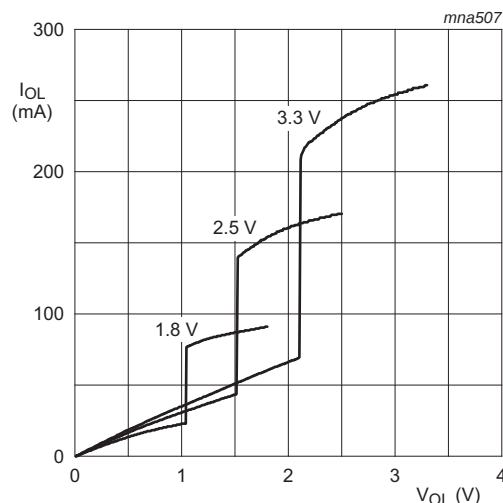


Fig 6. Output voltage as a function of the LOW-level output current.

10. Dynamic characteristics

Table 7. Dynamic characteristics

Voltages are referenced to GND (ground = 0 V). $t_r = t_f \leq 2$ ns. For test circuit, see [Figure 10](#).

Symbol	Parameter	Conditions	–40 °C to +85 °C			Unit
			Min	Typ ^[2]	Max	
t_{pd}	propagation delay	nCP to nQn; see Figure 7 ^[1]				
		$V_{CC} = 1.2$ V	-	3.1	-	ns
		$V_{CC} = 1.4$ V to 1.6 V	1.2	2.4	8.4	ns
		$V_{CC} = 1.65$ V to 1.95 V	1.0	2.0	6.7	ns
		$V_{CC} = 2.3$ V to 2.7 V	0.8	1.5	4.1	ns
		$V_{CC} = 3.0$ V to 3.6 V	0.7	1.3	3.3	ns
t_{en}	enable time	nOE to nQn, nBn; see Figure 8 ^[1]				
		$V_{CC} = 1.2$ V	-	5.4	-	ns
		$V_{CC} = 1.4$ V to 1.6 V	1.6	3.9	8.5	ns
		$V_{CC} = 1.65$ V to 1.95 V	2.3	3.3	6.7	ns
		$V_{CC} = 2.3$ V to 2.7 V	0.9	2.3	4.3	ns
		$V_{CC} = 3.0$ V to 3.6 V	0.7	2.0	3.4	ns
t_{dis}	disable time	nOE to nQn; see Figure 8 ^[1]				
		$V_{CC} = 1.2$ V	-	5.6	-	ns
		$V_{CC} = 1.4$ V to 1.6 V	2.5	4.5	9.4	ns
		$V_{CC} = 1.65$ V to 1.95 V	1.8	3.3	7.8	ns
		$V_{CC} = 2.3$ V to 2.7 V	1.0	1.8	4.2	ns
		$V_{CC} = 3.0$ V to 3.6 V	1.2	2.0	3.9	ns

Table 7. Dynamic characteristics ...continued

Voltages are referenced to GND (ground = 0 V). $t_r = t_f \leq 2$ ns. For test circuit, see [Figure 10](#).

Symbol	Parameter	Conditions	–40 °C to +85 °C			Unit
			Min	Typ ^[2]	Max	
t_w	pulse width	HIGH; nCP; see Figure 7				
		$V_{CC} = 1.2$ V	-	0.8	-	ns
		$V_{CC} = 1.4$ V to 1.6 V	-	0.5	-	ns
		$V_{CC} = 1.65$ V to 1.95 V	3.1	0.3	-	ns
		$V_{CC} = 2.3$ V to 2.7 V	2.5	0.2	-	ns
		$V_{CC} = 3.0$ V to 3.6 V	2.5	0.2	-	ns
t_{su}	set-up time	nDn to nCP; see Figure 8				
		$V_{CC} = 1.2$ V	-	–0.6	-	ns
		$V_{CC} = 1.4$ V to 1.6 V	2.7	–0.3	-	ns
		$V_{CC} = 1.65$ V to 1.95 V	1.9	–0.3	-	ns
		$V_{CC} = 2.3$ V to 2.7 V	1.4	–0.2	-	ns
		$V_{CC} = 3.0$ V to 3.6 V	1.4	–0.1	-	ns
t_h	hold time	nDn to nCP; see Figure 8				
		$V_{CC} = 1.2$ V	-	0.8	-	ns
		$V_{CC} = 1.4$ V to 1.6 V	1.3	0.7	-	ns
		$V_{CC} = 1.65$ V to 1.95 V	1.2	0.6	-	ns
		$V_{CC} = 2.3$ V to 2.7 V	1.1	0.5	-	ns
		$V_{CC} = 3.0$ V to 3.6 V	1.1	0.4	-	ns
f_{max}	maximum frequency	see Figure 8				
		$V_{CC} = 1.2$ V	-	250	-	MHz
		$V_{CC} = 1.4$ V to 1.6 V	-	300	-	MHz
		$V_{CC} = 1.65$ V to 1.95 V	160	320	-	MHz
		$V_{CC} = 2.3$ V to 2.7 V	200	350	-	MHz
		$V_{CC} = 3.0$ V to 3.6 V	200	350	-	MHz
C_{PD}	power dissipation capacitance	per input; $V_I = \text{GND to } V_{CC}$ [3]				
		outputs enabled	-	66	-	pF
		outputs disabled	-	1	-	pF

[1] t_{pd} is the same as t_{PLH} and t_{PHL} .

t_{en} is the same as t_{PZL} and t_{PZH} .

t_{dis} is the same as t_{PLZ} and t_{PHZ} .

[2] Typical values are measured at $T_{amb} = 25$ °C and $V_{CC} = 1.2$ V, 1.5 V, 1.8 V, 2.5 V and 3.3 V respectively.

[3] C_{PD} is used to determine the dynamic power dissipation (P_D in μ W).

$P_D = C_{PD} \times V_{CC}^2 \times f_i \times N + \Sigma(C_L \times V_{CC}^2 \times f_o)$ where:

f_i = input frequency in MHz; f_o = output frequency in MHz

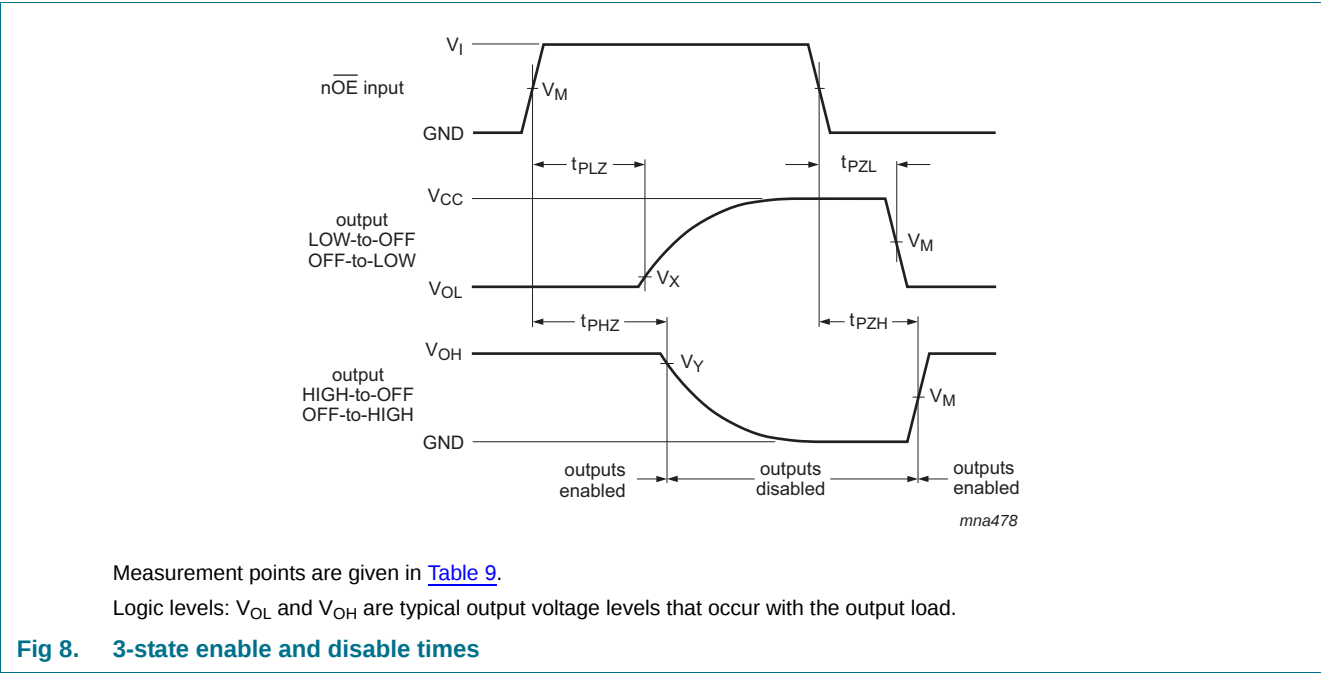
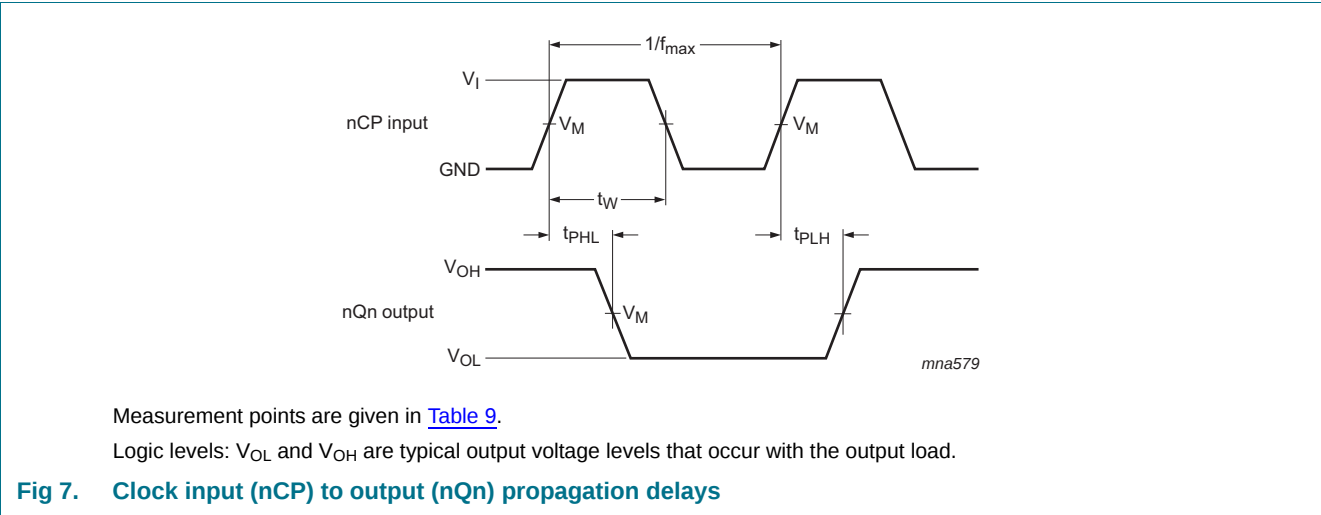
C_L = output load capacitance in pF

V_{CC} = supply voltage in Volts

N = number of inputs switching

$\Sigma(C_L \times V_{CC}^2 \times f_o)$ = sum of the outputs.

11. Waveforms



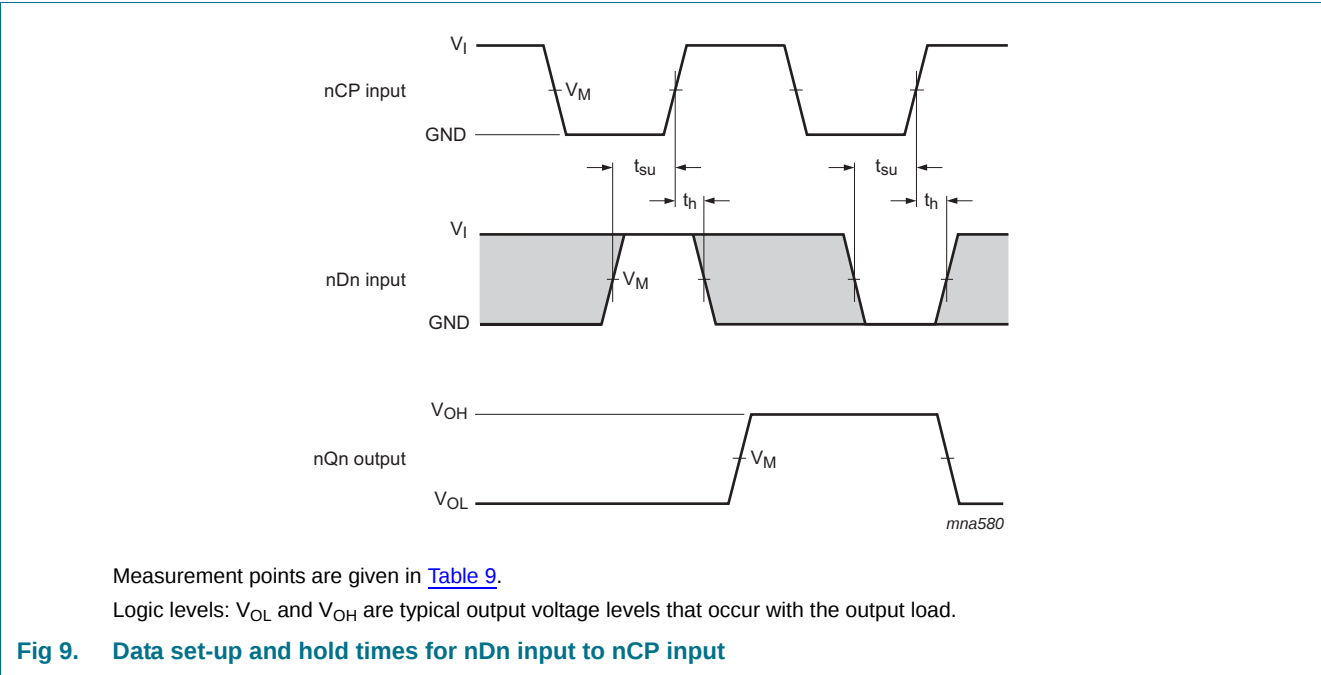
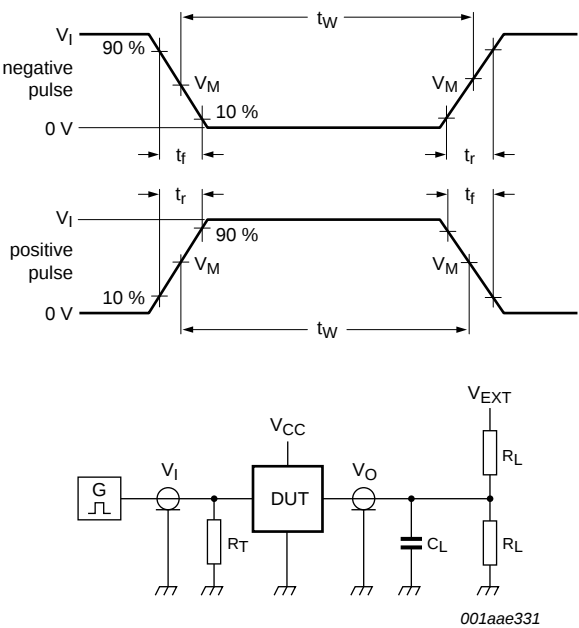


Table 8. Measurement points

Supply voltage	V_M	Input			
V_{CC}		V_I	$t_r = t_f$	V_X	V_Y
1.2 V	$0.5 \times V_{CC}$	V_{CC}	$\leq 2 \text{ ns}$	$V_{OL} + 0.15 \text{ V}$	$V_{OH} - 0.15 \text{ V}$
1.4 V to 1.6 V	$0.5 \times V_{CC}$	V_{CC}	$\leq 2 \text{ ns}$	$V_{OL} + 0.15 \text{ V}$	$V_{OH} - 0.15 \text{ V}$
1.65 V to 1.95 V	$0.5 \times V_{CC}$	V_{CC}	$\leq 2 \text{ ns}$	$V_{OL} + 0.15 \text{ V}$	$V_{OH} - 0.15 \text{ V}$
2.3 V to 2.7 V	$0.5 \times V_{CC}$	V_{CC}	$\leq 2 \text{ ns}$	$V_{OL} + 0.15 \text{ V}$	$V_{OH} - 0.15 \text{ V}$
3.0 V to 3.6 V	$0.5 \times V_{CC}$	V_{CC}	$\leq 2 \text{ ns}$	$V_{OL} + 0.3 \text{ V}$	$V_{OH} - 0.3 \text{ V}$



Test data is given in [Table 9](#).
Definitions for test circuit:
 R_L = Load resistance.
 C_L = Load capacitance including jig and probe capacitance.
 R_T = Termination resistance should be equal to output impedance Z_o of the pulse generator.
 V_{EXT} = External voltage for measuring switching times.

Fig 10. Test circuit for measuring switching times

Table 9. Test data

Supply voltage	Input		Load		V_{EXT}		
	V_I	t_r, t_f	C_L	R_L	t_{PLH}, t_{PHL}	t_{PLZ}, t_{PZL}	t_{PHZ}, t_{PZH}
1.2 V	V_{CC}	≤ 2 ns	15 pF	2 k Ω	open	$2 \times V_{CC}$	GND
1.4 V to 1.6 V	V_{CC}	≤ 2 ns	15 pF	2 k Ω	open	$2 \times V_{CC}$	GND
1.65 V to 1.95 V	V_{CC}	≤ 2 ns	30 pF	1 k Ω	open	$2 \times V_{CC}$	GND
2.3 V to 2.7 V	V_{CC}	≤ 2 ns	30 pF	500 Ω	open	$2 \times V_{CC}$	GND
3.0 V to 3.6 V	V_{CC}	≤ 2 ns	30 pF	500 Ω	open	$2 \times V_{CC}$	GND

12. Package outline

TSSOP48: plastic thin shrink small outline package; 48 leads; body width 6.1 mm

SOT362-1

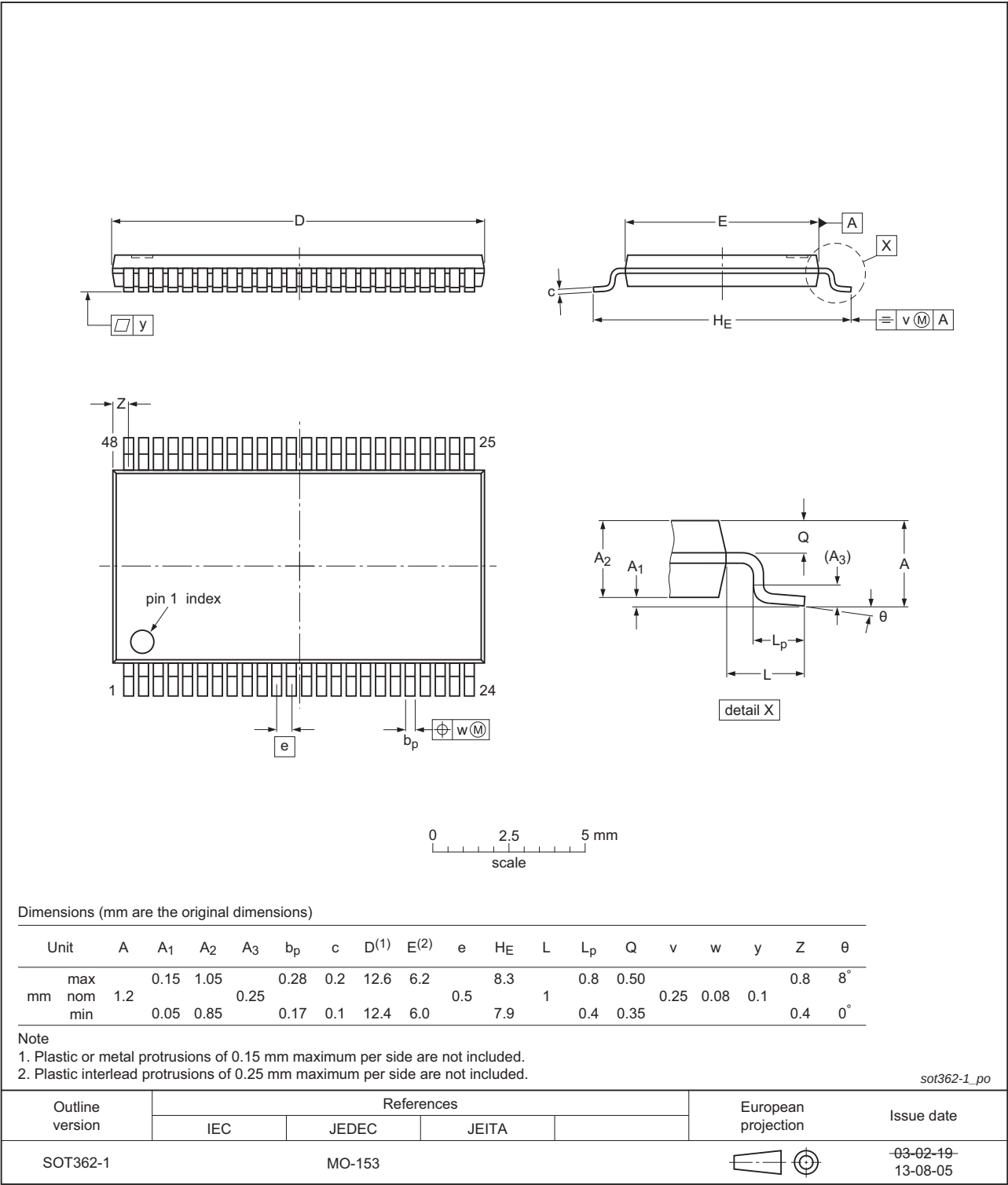


Fig 11. Package outline SOT362-1 (TSSOP48)

13. Abbreviations

Table 10. Abbreviations

Acronym	Description
CMOS	Complementary Metal-Oxide Semiconductor
DUT	Device Under Test
TTL	Transistor-Transistor Logic

14. Revision history

Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Order number	Supersedes
74AVC16374 v.3	20130816	Product data sheet	-	-	74AVC16374 v.2
Modifications:	- The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors. - Legal texts have been adapted to the new company name where appropriate.				
74AVC16374 v.2	20000309	Product specification	-	-	74AVC16374 v.1
74AVC16374 v.1	19981211	Product specification	-	-	-

15. Legal information

15.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <http://www.nxp.com>.

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